Search Notes

7	Application/Control No.	Applicant(s)/Patent un Reexamination	der
1	10/029,439	TANAKA ET AL.	
E	Examiner	Art Unit	
F	PHUC H. TRAN	2666	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	229-235 368,371 374,378 381,382	8/24/2005	РТ
370	383,395.7	8/24/2005	PT
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Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	8/23/2005	5 PT		
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